

<b>Notice of References Cited</b>	Application/Control No. 10/066,663	Applicant(s)/Patent Under Reexamination AHN, SEUNG KEUN
	Examiner Paul Huber	Art Unit 2653

**U.S. PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
A	US-6,195,778	02-2001	Tran, Phuc Thanh	714/752
B	US-6,014,094	01-2000	Hayashiyama et al.	341/58
C	US-5,638,064	06-1997	Mori et al.	341/58
D	US-			
E	US-			
F	US-			
G	US-			
H	US-			
I	US-			
J	US-			
K	US-			
L	US-			
M	US-			

**FOREIGN PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N					
O					
P					
Q					
R					
S					
T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.